

<b>Notice of References Cited</b>		Application/Control No. 10/577,225	Applicant(s)/Patent Under Reexamination KATATA ET AL.	
		Examiner HENOK HEYI	Art Unit 2627	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0059205 A1	03-2003	Suzuki, Ryoichi	386/94
*	B	US-2003/0137909 A1	07-2003	Ito et al.	369/47.14
*	C	US-2003/0179669 A1	09-2003	Takahashi et al.	369/47.14
*	D	US-2003/0193859 A1	10-2003	Mitsuda et al.	369/47.13
*	E	US-2005/0237877 A1	10-2005	Yamanaka, Yutaka	369/044.26
*	F	US-2007/0201343 A1	08-2007	Kuroda et al.	369/275.3
*	G	US-7,551,532 B2	06-2009	Hwang et al.	369/47.14
H	US-				
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.